

# Anti-Pillow Defect Lead Free Solder Paste

## S3X48-M500

**PREVENTS** the occurrence of **HIDDEN PILLOW DEFECT** (Head in Pillow) and ensures the highest quality of solder joints.

Drastically **REDUCES VOIDING** especially with large contact area components, such as power transistors, LGAs0and QFNs, and is particularly well suited to automotive applications.

Significant **REDUCTION** of **HALOGEN** from the flux formulation helps to prevent environmental pollution.

#### **Background of development**

Using mobile telephones as a typical example, whilst downsizing of the electronic devices continues, more and more space saving components, such as BGAs and CSPs, are being widely used. It has become a critical issue when complete solder merging between the bumps and solder does not occur, and is referred to as "hidden pillow defect" or "head in pillow" under certain conditions.

The solder paste S3X48-M500 has been specifically developed to solve this difficult technical problem, not only for bumped components such as BGAs, but also exhibits excellent wetting with all other types of components.



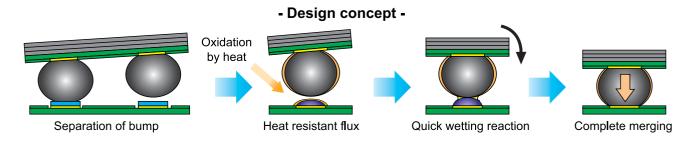
Pillow defect

#### Mechanism of occurrence of Pillow Defect

For various reasons, such as package warpage and co-planarity, inconsistent bump size, insufficient solder deposit, distortion of package during reflow etc., will induce the solder bump to be separated from the solder paste before the solder melts and wets to it. In such cases where the solder bump separates from the solder paste, during heating in the reflow oven, an adverse effect occurs in two areas. Firstly, the area of the bump surface where it is in contact with the molten solder gets badly oxidized, and secondly, the flux activation of the solder paste will be too quickly consumed as the solder melts, thus forming a layer of oxidized flux and solder on the surface.

When the bump descends onto the molten solder due to the weight of the package and wetting forces from the other joints, the oxide film formed on the surface of the molten solder paste and the molten solder bump with almost no flux activation, prohibits them from fully merging together.

It seems difficult to completely prevent the separation of the bumps from the solder paste, so it is critical to develop the solder paste featuring **high heat resistance** characteristics to protect the solder powder and bump from oxidation and sustain the activation strength of the flux for a long time at high temperatures. Furthermore it is necessary to facilitate **quick wetting reaction speeds** to reduce the exposure time of the solder bump and secure sufficient time for the bump to collapse and merge with the molten solder paste.



#### **Anti-Pillow defect**

Significant enhancements in the heat resistance of the flux and wetting reaction speed have succeeded in reducing the occurrence of hidden pillow defect.

S3X48-M500 assures robust wetting action to BGA bumps even with intentional extra oxidation.

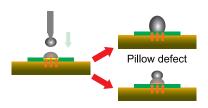
#### ► Retention of flux activation

The influence of progressive oxidation of flux/molten solder over retention of flux activation.

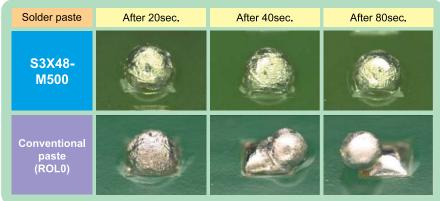
· Stencil: 0.12mm thickness, 100% stencil aperture to pad size

Pad: 0.8 x 0.8mm chip padSolder ball: Sn3Ag0.5Cu, 0.76mm diameter

· Test procedure : Melt solder paste on hot plate and drop solder ball at every 20sec.



Drop solder ball every 10 sec. after the solder paste has melted to see heat durability of flux.



#### ► Pillow defect test

· Material : Glass epoxy FR-4 · Surface treatment : OSP

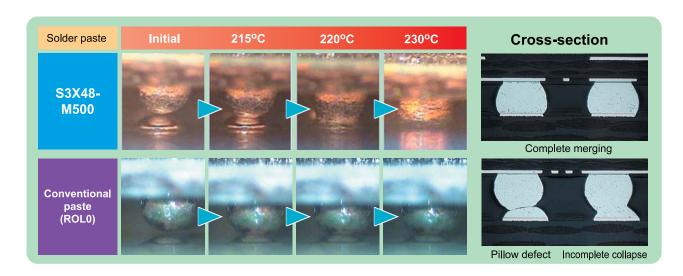
· Stencil thickness: 0.12mm · Stencil aperture: 100% aperture opening to pad

Pad size: 0.5mm Reflow Atmosphere: Air

Component (BGA): SnAgCu, 1.0mm pitch, 196 bumps x 5, pre-conditioned at 180°C x 100sec.
 Procedure: 1. Reflow solder paste without BGA.

2. Place BGA on post-reflowed solder.

3. Reflow it.



New formula S3X48-M500 wets much faster than the conventional product and immediately breaks the oxide film formed on the surface of both the solder bump and the molten solder and enables quicker wetting and complete collapse of the bump to ensure joint quality.

S3X48-M500 succeeded in securing a drastic reduction of pillow defects.

#### Low voiding

#### ► Voiding behavior with different surface finish

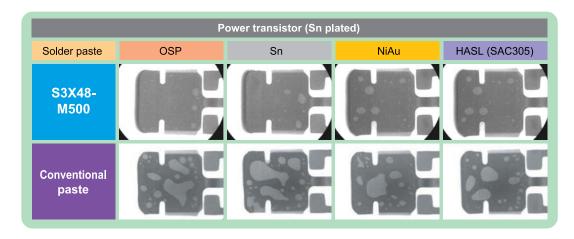
A variety of optimizations to the flux formulation combined with a newly adopted activator system and much lower boiling point materials have succeeded to remove flux gases from the solder joint. This dynamic evacuation is swift and highly effective regardless of the types of surface finish and components used in the assembly.

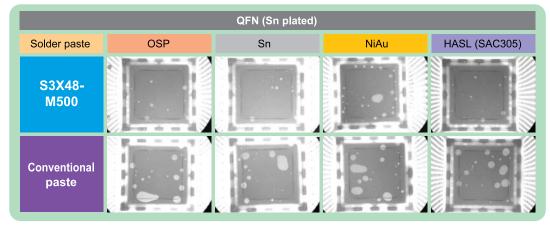
· Material : Glass epoxy FR-4

· Surface treatment : OSP, NiAu, Sn, HASL(SAC305)

Stencil thickness:
 Components:
 0.12mm (laser cut) / 100% aperture opening to pad
 Power transistor, QFN, (both 100% Sn plated)

· Atmosphere : Air





### **Halogen Free**

#### **▶** Background of development

Recent increasing consciousness about ecology on a global scale has started considerations for the restriction of certain elements within soldering materials used within the electronics industry.

Ever since it's been reported that dioxins can be generated when specific kinds of halide are combusted, there have been moves afoot to eliminate halogens from soldering materials, such as solder pastes and wave soldering fluxes.

Koki's research and development team have been working on this "halogen free" issue for many years and provided various products already. S3X48-M500 is the latest and fully developed product as a true "halogen free" solder paste meeting the below Halogen Free criteria.

Substance	Permissible limit (by weight)	Actual halogen content (Analysis results by outside lab)
Chlorine (CI)	≤ 900 ppm (0.09%)	ND
Bromine (Br)	≤ 900 ppm (0.09%)	103 ppm
Total concentration of CI+Br	≤ 1500 ppm (0.15%)	103 ppm

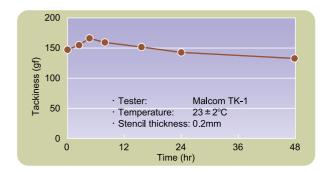
Test method: EN14582: 2007



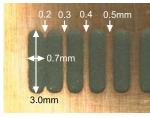
#### Stencil idle time

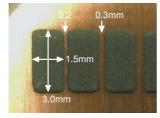


#### **Tack time**

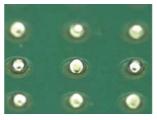


### Heat slump





#### Solder wetting





03mm dia. CSP pattern (OSP)

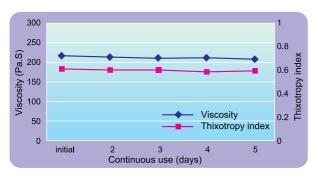
OSP board

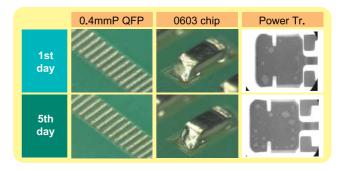
0603 chip (100Sn)

#### **Durability (repeated use)**

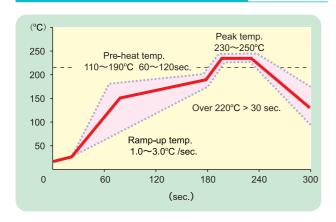
Test design enables a solder paste to be monitored under repeated use. **S3X48-M500** indicated consistent quality and performance over the period of 5 days of repeated use without any quality degradation.

- · Rolling condition: 30mm/sec. x 300mm stroke, squeegee length 250mm
- Procedure: Vscosity/Ti checki→Put 500g of fresh paste on stencili→Continuous rolling for 8hours/Check printability, wetting & voidingí→Keep it in refrigerator over nightí→Dispose of 250g add 250g of fresh pasteí→Viscosity/Ti checki→Continue rolling for 8hours/check rest of featuresí→Repeat this for 4 days





### Recommended reflow profile



### **Specifications**

Application		Printing - Stencil
Products		S3X48-M500
Alloy	Composition (%)	Sn96.5, Ag3.0, Cu0.5
	Melting point (°C)	217 - 219
	Particle size (µm)	20 - 45
Flux	Halide content (%)	0.0
	Flux type*	ROL0
Product	Flux content (%)	11.5
	Viscosity (Pa.S)	220
	Copper mirror*	Pass
	Quantitative halide content(%)*	< 0.05
	SIR*	Pass
	Tack time	> 48 hours
	Shelf life (below 10°C)	6 months
	Optional powder(µm)	20 - 38; <i>S3X58-M500</i>
*ANSI/J-STD-004A (IPC-TM-650)		Specifications are subject to change

## KOKI COMPANY LIMITED



